Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,430	BYON, KYUNG-SAM	
Examiner	Art Unit	
John P. Lacyk	3735	

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	SEARCHED				
Class	Subclass	Date	Examiner		
600	38-41				
601	6-14	5/26/2006	· JPL		
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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Interference Search History Printout		JPL	
	Subclass	Subclass Date	

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